

# 50 MIPS, 16 kB Flash, 12-Bit ADC, 32-Pin Automotive MCU

# **Analog Peripherals**

## 12-Bit ADC, 5 V input signal; up to 25 external inputs

- ±1 LSB INL; guaranteed monotonic
- Programmable throughput up to 200 ksps
- Data-dependent windowed interrupt generator
- Programmable gain maximizes input signal span

## Built-in Temperature Sensor (±3 °C)

#### **Two Comparators**

### **Precision Internal Voltage Reference**

# **V<sub>DD</sub> Monitor/Brown-out Detector**

# On-Chip Debug

- On-chip debug circuitry facilitates full speed, non-intrusive in-system debug (no emulator required)
- Provides breakpoints, single stepping, watch-points
- Inspect/modify memory, registers, and stack
- Superior performance to emulation systems using ICE-chips, target pods, and sockets

# Temperature Range: -40 to +125 °C Operating Voltage: 1.8 to 5.25 V - Multiple power saving sleep and shutdown modes

**Development Kit: C8051F540DK** 

# High-Speed 8051 µC Core

- Pipelined instruction architecture; executes 70% of instructions in one or two system clocks
- Up to 50 MIPS throughput

### Memory

- 16 kB Flash; in-system programmable; flexible security features
- 1280 bytes data RAM (256 + 1 kB)

## **Digital Peripherals**

- Up to 25 digital I/O; all are 5 V push-pull
- Hardware I<sup>2</sup>C, SPI™, and UART serial ports available concurrently
- Programmable 16-bit counter array with six capture/compare modules
- Four general-purpose 16-bit counter/timers

#### **Clock Sources**

- Internal programmable ±0.5% oscillator: up to 50 MHz
- External oscillator: Crystal, RC, C, or CMOS Clock

## **Ordering Part Numbers**

- C8051F541-IM, 32-Pin QFN (RoHS-compliant), 5 x 5 mm<sup>2</sup>
- C8051F541-IQ, 32-Pin QFP (RoHS-compliant), 9 x 9 mm<sup>2</sup>

